



N-Channel NexFET™ Power MOSFET

Check for Samples: CSD13201W10

FEATURES

- Ultra Low Qg and Qgd
- Small Footprint 1mm x 1mm
- Low Profile 0.62mm Height
- Pb Free
- RoHS Compliant
- Halogen Free
- Gate-Source Voltage Clamp

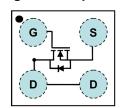
APPLICATIONS

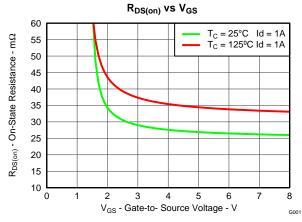
- Battery Management
- Load Switch
- Battery Protection

DESCRIPTION

The device has been designed to deliver the lowest on resistance and gate charge in the smallest outline possible with excellent thermal characteristics in an ultra low profile.

Figure 1. Top View





PRODUCT SUMMARY

V_{DS}	Drain to Source Voltage	12	V		
Q_g	Gate Charge Total (4.5V)	2.3	nC		
Q_{gd}	Gate Charge Gate to Drain	0.3	nC		
R _{DS(on)}		$V_{GS} = 1.8V$	38	mΩ	
	Drain to Source On Resistance	V _{GS} = 2.5V	29	11177	
		V _{GS} = 4.5V 26		mΩ	
V _{GS(th)}	Threshold Voltage	0.8		V	

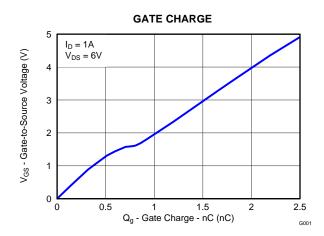
ORDERING INFORMATION

Device	Package	Media	Qty	Ship
CSD13201W10	1 x 1 Wafer Level Package	7-inch reel	3000	Tape and Reel

ABSOLUTE MAXIMUM RATINGS

T _A = 25°C ι	ınless otherwise stated	VALUE	UNIT
V_{DS}	Drain to Source Voltage	12	٧
V_{GS}	Gate to Source Voltage	±8	٧
I _D	Continuous Drain Current, $T_A = 25^{\circ}C^{(1)}$	1.6	Α
I _{DM}	Pulsed Drain Current, T _A = 25°C ⁽²⁾	20.2	Α
P_D	Power Dissipation ⁽¹⁾	1.2	W
T _J , T _{STG}	Operating Junction and Storage Temperature Range	-55 to 150	°C

- (1) $R_{\theta JA} = 105^{\circ} C/W$ on $1 in^2 Cu$ (2 oz.) on 0.060" thick FR4 PCB.
- (2) Pulse width \leq 300 µs, duty cycle \leq 2%



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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

ELECTRICAL CHARACTERISTICS

(T_A = 25°C unless otherwise stated)

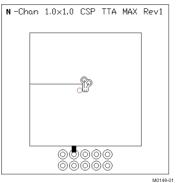
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Static Ch	aracteristics					
BV _{DSS}	Drain to Source Voltage	$V_{GS} = 0V, I_D = 250\mu A$	12			V
I _{DSS}	Drain to Source Leakage Current	V _{GS} = 0V, V _{DS} = 9.6V			1	μΑ
I _{GSS}	Gate to Source Leakage Current	V _{DS} = 0V, V _{GS} = 8V			100	nA
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.65	0.8	1.1	V
		V _{GS} = 1.8V, I _D = 1A		38	53	mΩ
R _{DS(on)}	Drain to Source On Resistance	V _{GS} = 2.5V, I _D = 1A		29	39	
		V _{GS} = 4.5V, I _D = 1A		26	34	mΩ
9 _{fs}	Transconductance	V _{DS} = 6V, I _D = 1A		23		S
Dynamic	Characteristics				*	
C _{ISS}	Input Capacitance			385	462	pF
Coss	Output Capacitance	V _{GS} = 0V, V _{DS} = 6V, f = 1MHz		245	294	pF
C _{RSS}	Reverse Transfer Capacitance			18.1	22.6	pF
R _g	Series Gate Resistance			3		Ω
Qg	Gate Charge Total (4.5V)			2.3	2.9	nC
Q _{gd}	Gate Charge Gate to Drain	V _{DS} = 6V, I _D = 1A		0.3		nC
Q _{gs}	Gate Charge Gate to Source			0.5		nC
Q _{g(th)}	Gate Charge at Vth			0.3		nC
Q _{OSS}	Output Charge	$V_{DS} = 6.0V, V_{GS} = 0V$		1.8		nC
t _{d(on)}	Turn On Delay Time			3.9		ns
t _r	Rise Time	$V_{DS} = 6V, V_{GS} = 4.5V, I_{D} = 1A$		5.9		ns
t _{d(off)}	Turn Off Delay Time	$R_G = 20\Omega$		14.4		ns
t _f	Fall Time			9.7		ns
Diode Ch	aracteristics					
V _{SD}	Diode Forward Voltage	I _S = 1A, V _{GS} = 0V		0.7	1	V
Q _{rr}	Reverse Recovery Charge	V 0V I 40 EVI 4000		2.4		nC
t _{rr}	Reverse Recovery Time	V_{DS} = 6V, I_{S} = 1A, di/dt = 100A/ μ s		11.5		ns

THERMAL CHARACTERISTICS

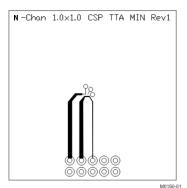
 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

	PARAMETER	MIN	TYP	MAX	UNIT
$R_{\theta JA}$	Thermal Resistance Junction to Ambient (Minimum Cu area)			228.6	°C/W
$R_{\theta JA}$	Thermal Resistance Junction to Ambient (1 in ² Cu area)			131.1	°C/W

Submit Documentation Feedback



Max $R_{\theta JA} = 131.1^{\circ}C/W$ when mounted on 1inch² of 2 oz. Cu.



Max $R_{\theta JA} = 228.6^{\circ} C/W$ when mounted on minimum pad area of 2 oz. Cu.

TYPICAL MOSFET CHARACTERISTICS

(T_A = 25°C unless otherwise stated)

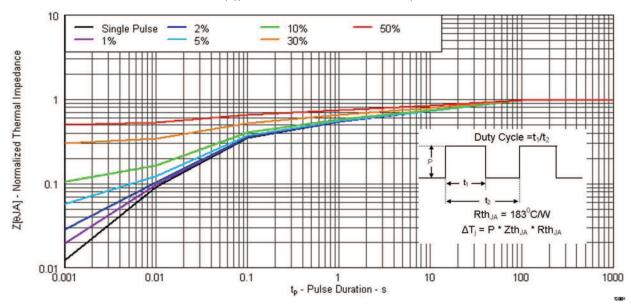


Figure 2. Transient Thermal Impedance

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TYPICAL MOSFET CHARACTERISTICS (continued)

(T_A = 25°C unless otherwise stated)

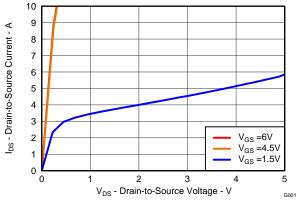
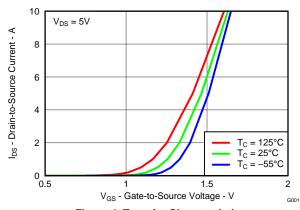
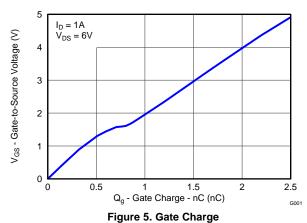


Figure 3. Saturation Characteristics



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Figure 4. Transfer Characteristics



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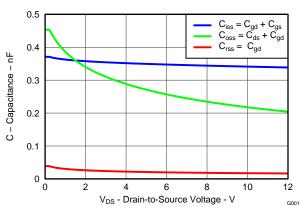


Figure 6. Capacitance

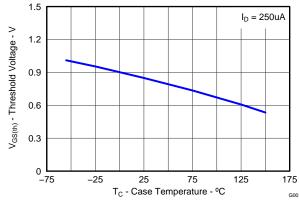


Figure 7. Threshold Voltage vs. Temperature

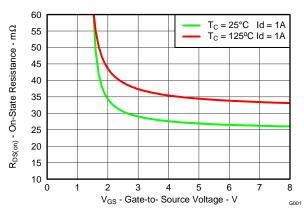


Figure 8. On Resistance vs. Gate Voltage



TYPICAL MOSFET CHARACTERISTICS (continued)

(T_A = 25°C unless otherwise stated)

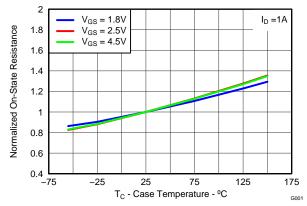


Figure 9. On Resistance vs. Temperature

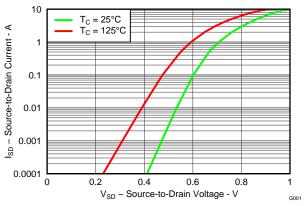


Figure 10. Typical Diode Forward Voltage

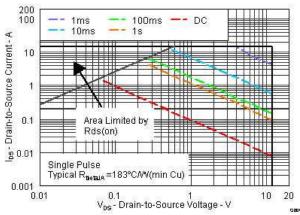


Figure 11. Maximum Safe Operating Area

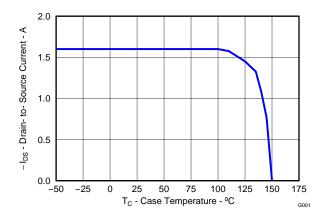


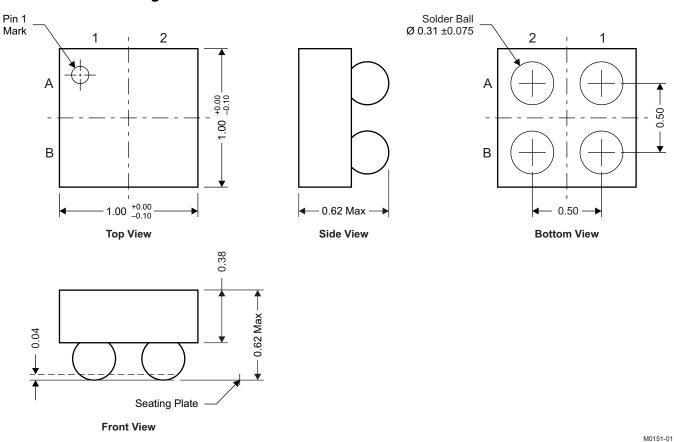
Figure 12. Maximum Drain Current vs. Temperature

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MECHANICAL DATA

CSD13201W10 Package Dimensions

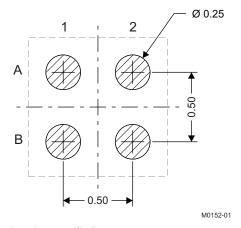


NOTE: All dimensions are in mm (unless otherwise specified)

Pin Configuration Table

3.1			
POSITION	DESIGNATION		
A2	Source		
A1	Gate		
B1, B2	Drain		

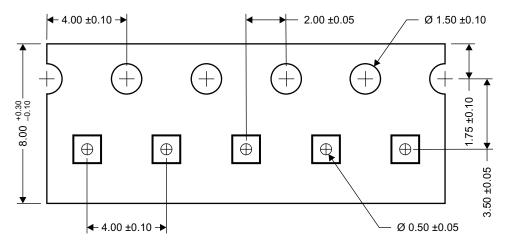
Land Pattern Recommendation

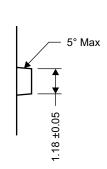


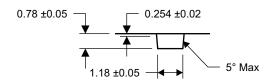
NOTE: All dimensions are in mm (unless otherwise specified)



Tape and Reel Information







M0153-01

NOTE: All dimensions are in mm (unless otherwise specified



PACKAGE OPTION ADDENDUM

17-Jun-2013

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Ū	Pins	U	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)		(3)		(4/5)	
CSD13201W10	PREVIEW	DSBGA	YZB	4	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	-50 to 150	201	

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

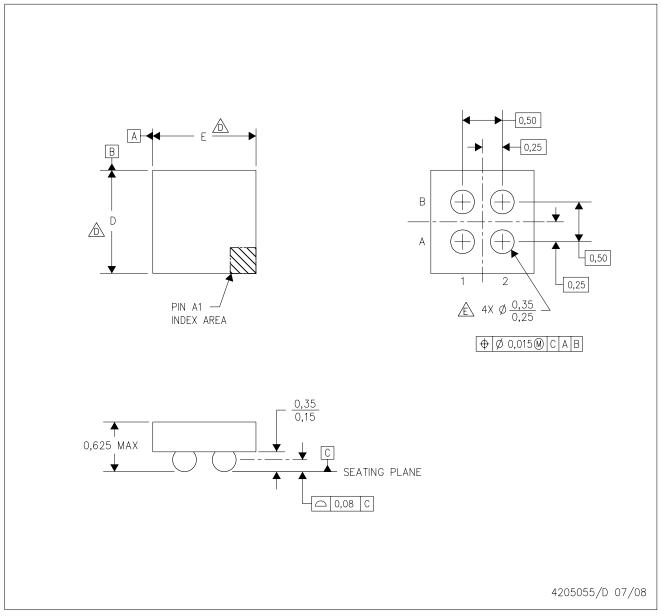
- (3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

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YZB (S-XBGA-N4)

DIE-SIZE BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. NanoFree™ package configuration.
- Devices in YZB package can have dimension D ranging from 0.94 to 1.65 mm and dimension E ranging from 0.94 to 1.65 mm.

 To determine the exact package size of a particular device, refer to the device datasheet or contact a local TI representative.
- E. Reference Product Data Sheet for array population. 2 x 2 matrix pattern is shown for illustration only.
- F. This package contains lead—free balls. Refer to YEB (Drawing #4204178) for tin—lead (SnPb) balls.



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